



<p style="text-align: center;">Searched</p> 	Application/Control No. 09232119	Applicant(s)/Patent Under Reexamination WEITZEL, THILO
	Examiner Kim, David S	Art Unit 2635 2613

Class	SubClass	Date	Examiner
398	202-214	5/3/2005	DSK
356	450-456	5/5/2005	DSK
356	451, 455	2/2/2006	DSK
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Notes	Date	Examiner
EAST search	4/28/2005	DSK, 5/2 - 5/5, 5/9/05
Internet search	5/2/2005	DSK, 5/3 - 5/5, 5/9 - 5/10/05
EAST search - see search history printout	1/26/2006	DSK, 1/28, 1/30, 1/31, 2/1, 2/2/06
www.google.com - various combinations of the following terms: mutually coherent heterodyne detection homodyne	2/3/2006	DSK
EAST search - see search history printout	9/22/2006	DSK
www.google.com - search terms: interferometer compensating plate wedge	9/22/2006	DSK
scholar.google.com - search terms: interferometer compensating plate wedge	9/22/2006	DSK
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